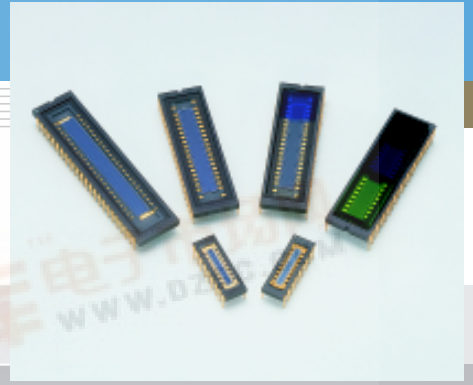


PHOTODIODE



Si photodiode array S4111/S4114 series

16, 35, 46 element Si photodiode array for UV to NIR

S4111/S4114 series are Si photodiode linear array mounted in ceramic DIPs (Dual Inline Packages). These photodiode arrays are primarily developed for low-light-level detection such as spectrophotometry, and cover a wide spectral range from UV to near infrared light. Since all elements can be used with a reverse bias for charge storage readout, S4111/S4114 series are able to detect low level light with high sensitivity. Cross-talk between elements is minimized to maintain signal purity. Special filters can be attached as the input window.

Features

- Large active area
- Low cross-talk
- Wide spectral response range
- High UV sensitivity
- Wide linearity
- S4111 series: Enhanced infrared sensitivity, low dark current
- S4114 series: Low terminal capacitance, high-speed response

Applications

- Multichannel spectrophotometers
- Color analyzers
- Light spectrum analyzers
- Light position detection

General ratings / Absolute maximum ratings

Type No.	Dimensional outline/ Window material *	Package (mm)	Active area (per 1 element)		Between elements measure (mm)	Between elements pitch (mm)	Number of elements	Absolute maximum ratings				
			Size (mm)	Effective area (mm ²)				Reverse voltage VR Max. (V)	Operating temperature T _{opr} (°C)	Storage temperature T _{stg} (°C)		
S4111-16Q	①/Q	18 pin DIP	1.45 × 0.9	1.305	0.1	1.0	16	15	-20 to +60	-20 to +80		
S4111-16R	②/R											
S4111-35Q	③/Q	40 pin DIP	4.4 × 0.9	3.96							35	
S4111-46Q	④/Q	48 pin DIP										46
S4114-35Q	③/Q	40 pin DIP										
S4114-46Q	④/Q	48 pin DIP										46

Electrical and optical characteristics (Typ. Ta=25 °C, per 1 element, unless otherwise noted)

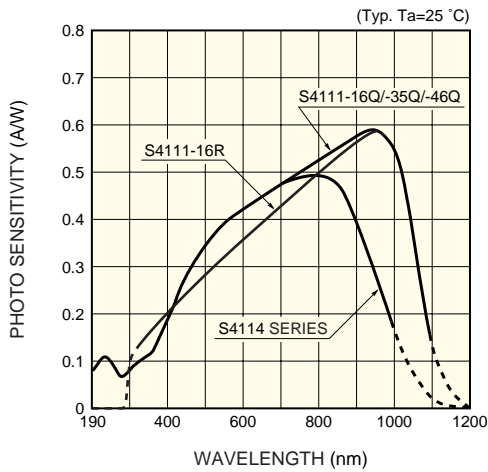
Type No.	Spectral response range λ (nm)	Peak sensitivity wavelength λ _p (nm)	Photo sensitivity S			Dark current I _D Max.		Shunt resistance R _{sh} VR=10 mV		Terminal capacitance C _t		Rise time t _r RL=1 kΩ λ=655 nm		NEP λ=λ _p													
			λ _p	200 nm	633 nm	VR=10 mV	VR=10 V	Min	Typ.	VR=0 V	VR=10 V	VR=0 V	VR=10 V	VR=0 V	VR=10 V												
			(A/W)	(A/W)	(A/W)	(pA)	(pA)	(GΩ)	(GΩ)	(pF)	(pF)	(μs)	(μs)	(W/Hz ^{1/2})	(W/Hz ^{1/2})												
S4111-16Q	190 to 1100	960	0.58	0.08	0.43	5	25	2.0	250	200	50	0.5	0.1	4.4 × 10 ⁻¹⁶	1.7 × 10 ⁻¹⁵												
S4111-16R	320 to 1100			-	0.39																						
S4111-35Q	190 to 1100			800	0.50	0.08	0.43	10	50	1.0	30	550	120	1.2	0.3	1.3 × 10 ⁻¹⁵	3.1 × 10 ⁻¹⁵										
S4111-46Q																											
S4114-35Q	190 to 1000																	60	300	0.15	2	35	20	0.1	0.05	5.7 × 10 ⁻¹⁵	3.0 × 10 ⁻¹⁵
S4114-46Q																											

* Window material R: resin coating, Q: quartz glass



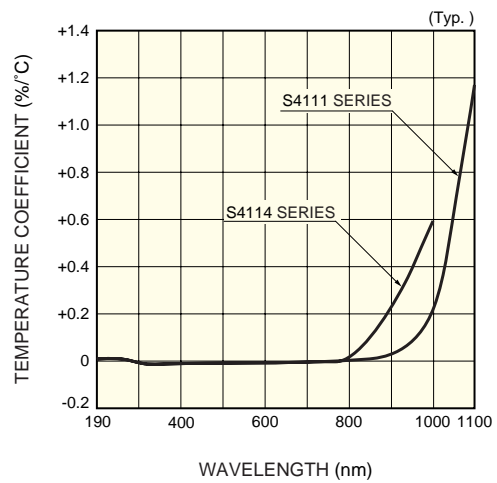
Si photodiode array S4111/S4114 series

■ Spectral response



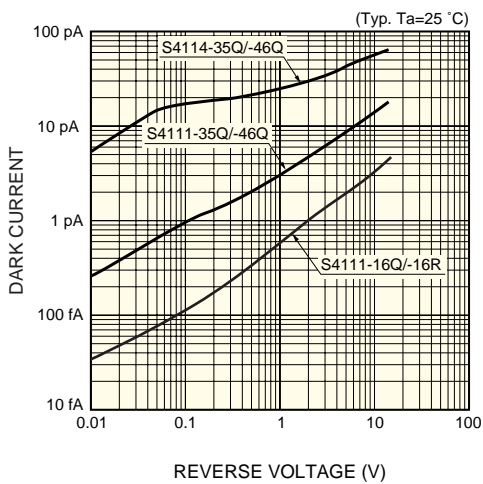
KMPDB0112EA

■ Photo sensitivity temperature characteristics



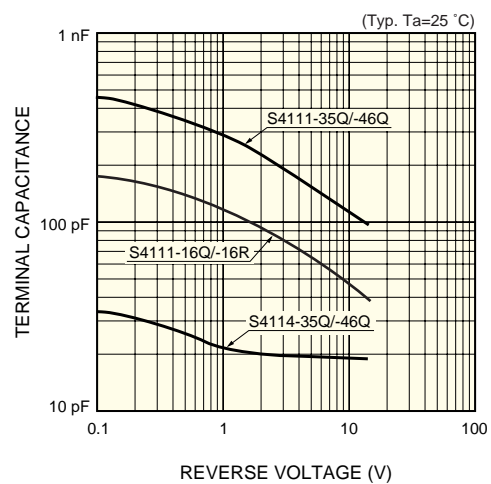
KMPDB0113EA

■ Dark current vs. reverse voltage



KMPDB0114EA

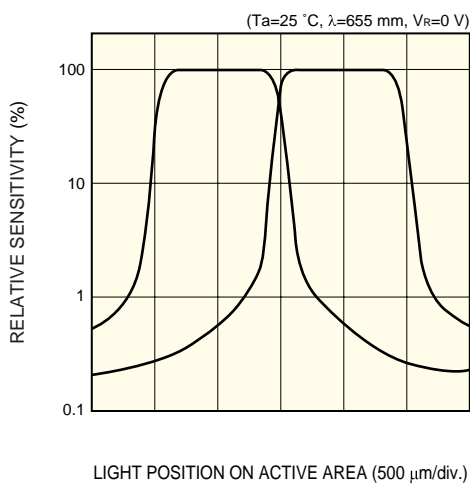
■ Terminal capacitance vs. reverse voltage



KMPDB0115EA

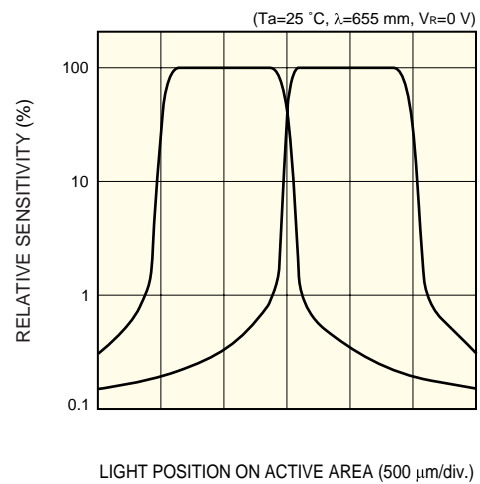
■ Example of cross-talk

S4111 series



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S4114 series

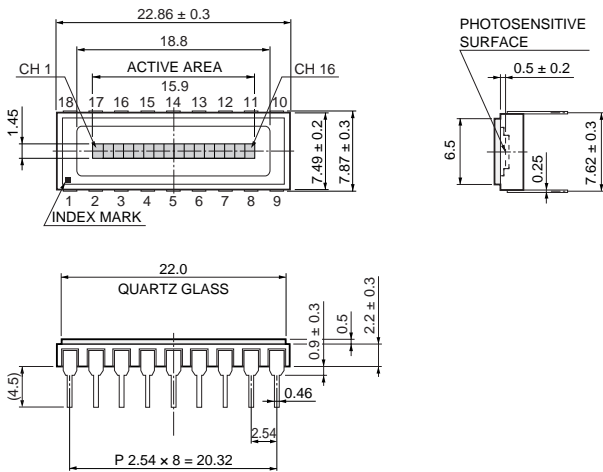


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Si photodiode array S4111/S4114 series

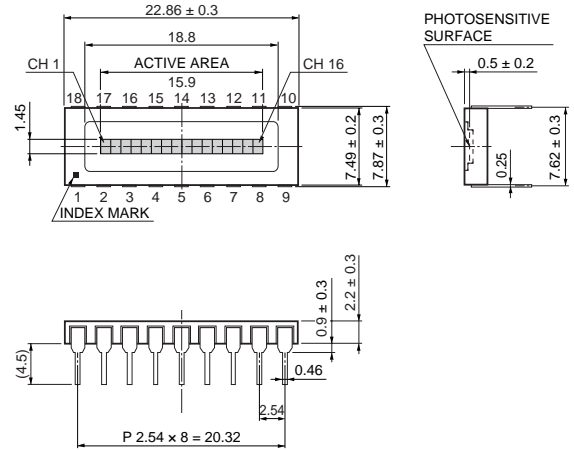
Dimensional outlines (unit: mm)

① S4111-16Q



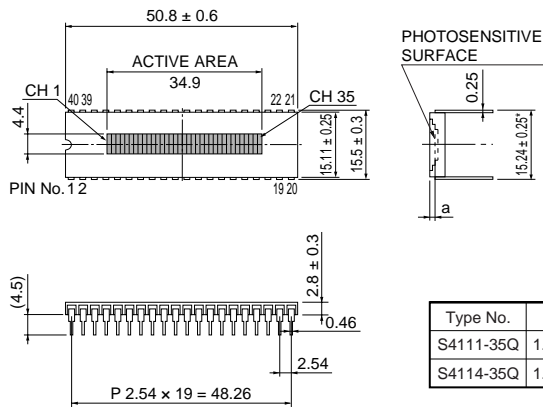
KMPDA0135EA

② S4111-16R



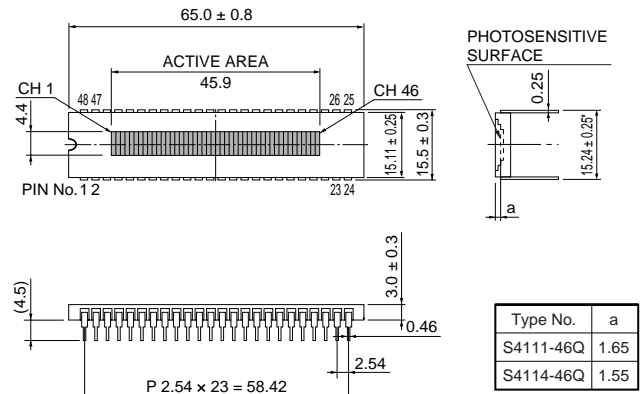
KMPDA0136EA

③ S4111-35Q, S4114-35Q



KMPDA0019EC

④ S4111-46Q, S4114-46Q



KMPDA0021EC

Details of elements (for all types)



KMPDA0112EA

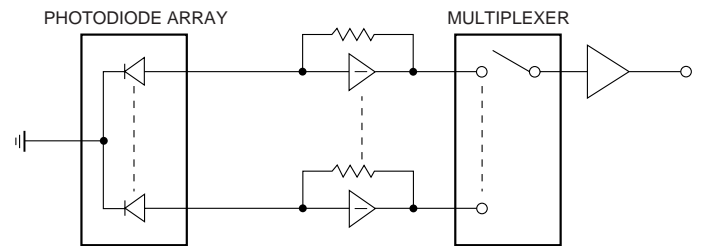
Si photodiode array S4111/S4114 series

Pin connections

Pin No.	16-element type	35-element type	46-element type
1	KC	KC	KC
2	2	2	2
3	4	4	4
4	6	6	6
5	8	8	8
6	10	10	10
7	12	12	12
8	14	14	14
9	16	16	16
10	KC	18	18
11	15	NC	20
12	13	20	22
13	11	22	24
14	9	24	26
15	7	26	28
16	5	28	30
17	3	30	32
18	1	32	34
19		34	36
20		NC	38
21		KC	40
22		35	42
23		33	44
24		31	46
25		29	KC
26		27	45
27		25	43
28		23	41
29		21	39
30		19	37
31		17	35
32		15	33
33		13	31
34		11	29
35		9	27
36		7	25
37		5	23
38		3	21
39		1	19
40		NC	17
41			15
42			13
43			11
44			9
45			7
46			5
47			3
48			1

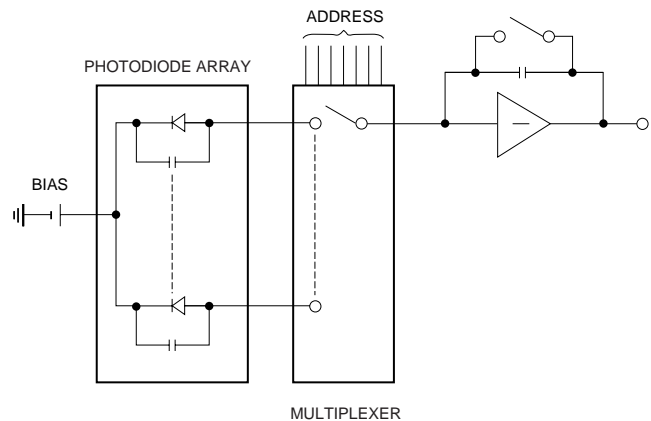
Operating circuits

- ① In the most generally used circuit, operational amplifiers are connected to each channel to read the output in real time. The output of an operational amplifier is of low impedance and thus can be easily multiplexed.



KMPDC0001EA

- ② In the charge storage readout method, the charge stored in the junction capacitance of each channel, which is proportional to the incident light intensity, can be read out in sequence by a multiplexer. With this method, reverse voltage must be applied to the photodiodes, so S4111 and S4114 series are suitable. One amplifier is sufficient but care should be taken regarding noise, dynamic range, etc.



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